

HEF4040B

12-stage binary ripple counter

Rev. 8 — 17 November 2011

Product data sheet

1. General description

The HEF4040B is a 12-stage binary ripple counter with a clock input (\overline{CP}), an overriding asynchronous master reset input (MR) and twelve fully buffered outputs (Q0 to Q11). The counter advances on the HIGH-to-LOW transition of \overline{CP} . A HIGH on MR clears all counter stages and forces all outputs LOW, independent of \overline{CP} . Each counter stage is a static toggle flip-flop. The clock input is highly tolerant of slow rise and fall times due to its Schmitt trigger action.

It operates over a recommended V_{DD} power supply range of 3 V to 15 V referenced to V_{SS} (usually ground). Unused inputs must be connected to V_{DD} , V_{SS} , or another input.

2. Features and benefits

- Tolerant of slow clock rise and fall time
- Fully static operation
- 5 V, 10 V, and 15 V parametric ratings
- Standardized symmetrical output characteristics
- Specified from -40°C to $+85^{\circ}\text{C}$
- Complies with JEDEC standard JESD 13-B

3. Applications

- Frequency dividing circuits
- Time delay circuits
- Control counters

4. Ordering information

Table 1. Ordering information

All types operate from -40°C to $+85^{\circ}\text{C}$.

Type number	Package		
	Name	Description	Version
HEF4040BP	DIP16	plastic dual in-line package; 16 leads (300 mil)	SOT38-4
HEF4040BT	SO16	plastic small outline package; 16 leads; body width 3.9 mm	SOT109-1



5. Functional diagram

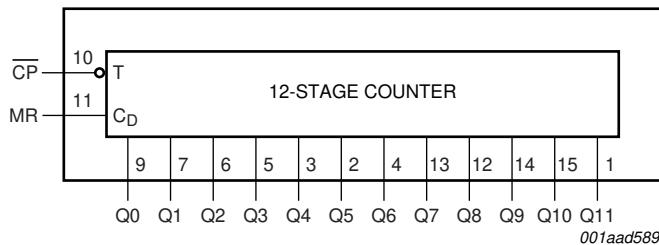


Fig 1. Functional diagram

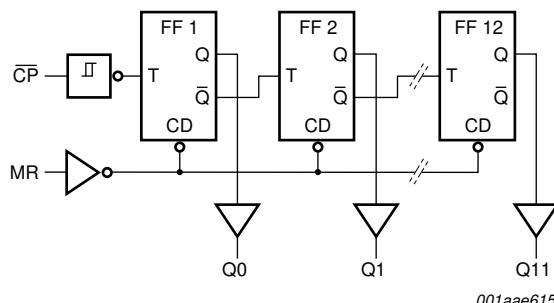


Fig 2. Logic diagram

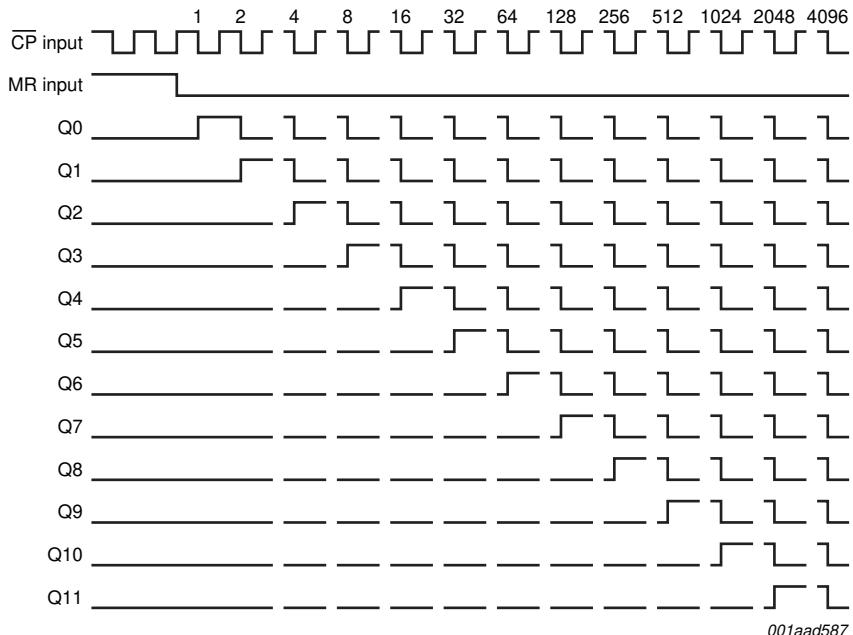


Fig 3. Timing diagram

6. Pinning information

6.1 Pinning

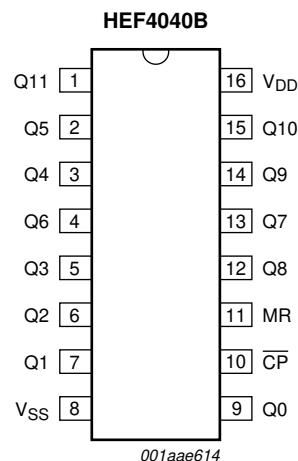


Fig 4. Pin configuration

6.2 Pin description

Table 2. Pin description

Symbol	Pin	Description
V _{SS}	8	ground supply voltage
Q0 to Q11	9, 7, 6, 5, 3, 2, 4, 13, 12, 14, 15, 1	parallel output
\overline{CP}	10	clock input (HIGH-to-LOW edge-triggered)
MR	11	master reset input (active HIGH)
V _{DD}	16	supply voltage

7. Limiting values

Table 3. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V _{DD}	supply voltage		-0.5	+18	V
I _{IK}	input clamping current	V _I < -0.5 V or V _I > V _{DD} + 0.5 V	-	±10	mA
V _I	input voltage		-0.5	V _{DD} + 0.5	V
I _{OK}	output clamping current	V _O < -0.5 V or V _O > V _{DD} + 0.5 V	-	±10	mA
I _{IO}	input/output current		-	±10	mA
I _{DD}	supply current		-	50	mA
T _{stg}	storage temperature		-65	+150	°C
T _{amb}	ambient temperature		-40	+85	°C
P _{tot}	total power dissipation	DIP16 package	[1] -	750	mW
		SO16 package	[2] -	500	mW
P	power dissipation	per output	-	100	mW

[1] For DIP16 package: P_{tot} derates linearly with 12 mW/K above 70 °C.[2] For SO16 package: P_{tot} derates linearly with 8 mW/K above 70 °C.

8. Recommended operating conditions

Table 4. Recommended operating conditions

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
V _{DD}	supply voltage		3	-	15	V
V _I	input voltage		0	-	V _{DD}	V
T _{amb}	ambient temperature	in free air	-40	-	+85	°C
Δt/ΔV	input transition rise and fall rate	V _{DD} = 5 V	-	-	3.75	ms/V
		V _{DD} = 10 V	-	-	0.5	ms/V
		V _{DD} = 15 V	-	-	0.08	ms/V

9. Static characteristics

Table 5. Static characteristicsV_{SS} = 0 V; V_I = V_{SS} or V_{DD}; unless otherwise specified.

Symbol	Parameter	Conditions	V _{DD}	T _{amb} = -40 °C		T _{amb} = 25 °C		T _{amb} = 85 °C		Unit
				Min	Max	Min	Max	Min	Max	
V _{IH}	HIGH-level input voltage	I _O < 1 μA	5 V	3.5	-	3.5	-	3.5	-	V
			10 V	7.0	-	7.0	-	7.0	-	V
			15 V	11.0	-	11.0	-	11.0	-	V
V _{IL}	LOW-level input voltage	I _O < 1 μA	5 V	-	1.5	-	1.5	-	1.5	V
			10 V	-	3.0	-	3.0	-	3.0	V
			15 V	-	4.0	-	4.0	-	4.0	V

Table 5. Static characteristics ...continued $V_{SS} = 0 \text{ V}$; $V_I = V_{SS} \text{ or } V_{DD}$; unless otherwise specified.

Symbol	Parameter	Conditions	V_{DD}	$T_{amb} = -40^\circ\text{C}$		$T_{amb} = 25^\circ\text{C}$		$T_{amb} = 85^\circ\text{C}$		Unit
				Min	Max	Min	Max	Min	Max	
V_{OH}	HIGH-level output voltage $ I_O < 1 \mu\text{A}$		5 V	4.95	-	4.95	-	4.95	-	V
			10 V	9.95	-	9.95	-	9.95	-	V
			15 V	14.95	-	14.95	-	14.95	-	V
V_{OL}	LOW-level output voltage $ I_O < 1 \mu\text{A}$		5 V	-	0.05	-	0.05	-	0.05	V
			10 V	-	0.05	-	0.05	-	0.05	V
			15 V	-	0.05	-	0.05	-	0.05	V
I_{OH}	HIGH-level output current $V_O = 2.5 \text{ V}$		5 V	-	-1.7	-	-1.4	-	-1.1	mA
			5 V	-	-0.52	-	-0.44	-	-0.36	mA
			10 V	-	-1.3	-	-1.1	-	-0.9	mA
			15 V	-	-3.6	-	-3.0	-	-2.4	mA
I_{OL}	LOW-level output current $V_O = 0.4 \text{ V}$		5 V	0.52	-	0.44	-	0.36	-	mA
			10 V	1.3	-	1.1	-	0.9	-	mA
			15 V	3.6	-	3.0	-	2.4	-	mA
I_{LI}	input leakage current		15 V	-	± 0.3	-	± 0.3	-	± 1.0	μA
I_{DD}	supply current $I_O = 0 \text{ A}$		5 V	-	20	-	20	-	150	μA
			10 V	-	40	-	40	-	300	μA
			15 V	-	80	-	80	-	600	μA
C_I	input capacitance		-	-	-	-	7.5	-	-	pF

10. Dynamic characteristics

Table 6. Dynamic characteristics $V_{SS} = 0 \text{ V}$; $T_{amb} = 25^\circ\text{C}$; unless otherwise specified; for test circuit see [Figure 6](#).

Symbol	Parameter	Conditions	V_{DD}	Extrapolation formula [1]	Min	Typ	Max	Unit
t_{PHL}	HIGH to LOW propagation delay $\overline{CP} \rightarrow Q_0$ see Figure 5		5 V	$78 \text{ ns} + (0.55 \text{ ns/pF})C_L$	-	105	210	ns
			10 V	$34 \text{ ns} + (0.23 \text{ ns/pF})C_L$	-	45	90	ns
			15 V	$27 \text{ ns} + (0.16 \text{ ns/pF})C_L$	-	35	70	ns
	$Q_n \rightarrow Q_{n+1}$		5 V	[2] $(0.55 \text{ ns/pF})C_L$	-	35	70	ns
			10 V	[2] $(0.23 \text{ ns/pF})C_L$	-	15	30	ns
			15 V	[2] $(0.16 \text{ ns/pF})C_L$	-	10	20	ns
	$MR \rightarrow Q_n$ see Figure 5		5 V	$63 \text{ ns} + (0.55 \text{ ns/pF})C_L$	-	90	180	ns
			10 V	$29 \text{ ns} + (0.23 \text{ ns/pF})C_L$	-	40	80	ns
			15 V	$22 \text{ ns} + (0.16 \text{ ns/pF})C_L$	-	30	60	ns
t_{PLH}	LOW to HIGH propagation delay $\overline{CP} \rightarrow Q_0$ see Figure 5		5 V	$58 \text{ ns} + (0.55 \text{ ns/pF})C_L$	-	85	170	ns
			10 V	$29 \text{ ns} + (0.23 \text{ ns/pF})C_L$	-	40	80	ns
			15 V	$22 \text{ ns} + (0.16 \text{ ns/pF})C_L$	-	30	60	ns
	$Q_n \rightarrow Q_{n+1}$		5 V	[2] $(0.55 \text{ ns/pF})C_L$	-	35	70	ns
			10 V	[2] $(0.23 \text{ ns/pF})C_L$	-	15	30	ns
			15 V	[2] $(0.16 \text{ ns/pF})C_L$	-	10	20	ns

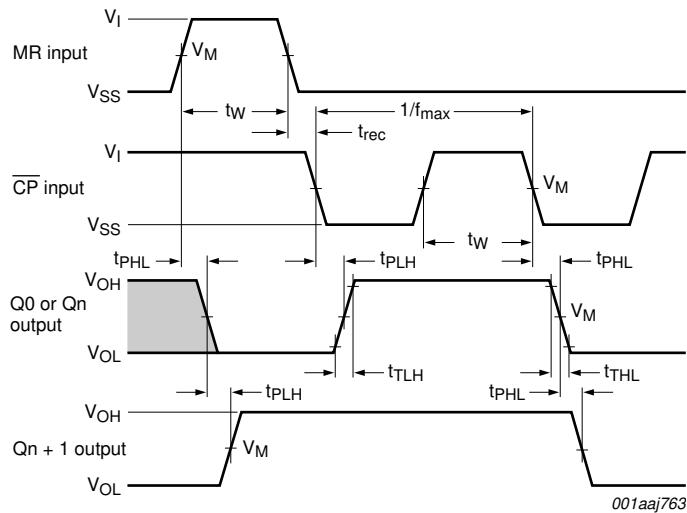
Table 6. Dynamic characteristics ...continued*V_{SS} = 0 V; T_{amb} = 25 °C; unless otherwise specified; for test circuit see [Figure 6](#).*

Symbol	Parameter	Conditions	V _{DD}	Extrapolation formula ^[1]	Min	Typ	Max	Unit
t _t	transition time	see Figure 5	5 V	[3] 10 ns + (1.00 ns/pF)C _L	-	60	120	ns
			10 V	9 ns + (0.42 ns/pF)C _L	-	30	60	ns
			15 V	6 ns + (0.28 ns/pF)C _L	-	20	40	ns
t _w	pulse width	CP input HIGH; minimum width; see Figure 5	5 V		50	25	-	ns
			10 V		30	15	-	ns
			15 V		20	10	-	ns
		MR input HIGH; minimum width; see Figure 5	5 V		40	20	-	ns
			10 V		30	15	-	ns
			15 V		20	10	-	ns
t _{rec}	recovery time	MR input; see Figure 5	5 V		40	20	-	ns
			10 V		30	15	-	ns
			15 V		20	10	-	ns
f _{max}	maximum frequency	CP input; see Figure 5	5 V		10	20	-	MHz
			10 V		15	30	-	MHz
			15 V		25	50	-	MHz

[1] The typical values of the propagation delay and transition times are calculated from the extrapolation formulas shown (C_L in pF).[2] For loads other than 50 pF at the nth output, use the slope given.[3] t_t is the same as t_{THL} and t_{TLH}.**Table 7. Dynamic power dissipation P_D***P_D can be calculated from the formulas shown. V_{SS} = 0 V; t_r = t_f ≤ 20 ns; T_{amb} = 25 °C.*

Symbol	Parameter	V _{DD}	Typical formula for P _D (μW)	where:
P _D	dynamic power dissipation	5 V	P _D = 400 × f _i + Σ(f _o × C _L) × V _{DD} ²	f _i = input frequency in MHz, f _o = output frequency in MHz,
		10 V	P _D = 2000 × f _i + Σ(f _o × C _L) × V _{DD} ²	C _L = output load capacitance in pF, V _{DD} = supply voltage in V,
		15 V	P _D = 5200 × f _i + Σ(f _o × C _L) × V _{DD} ²	Σ(f _o × C _L) = sum of the outputs.

11. Waveforms



Logic levels: V_{OL} and V_{OH} are typical output voltage levels that occur with the output load.

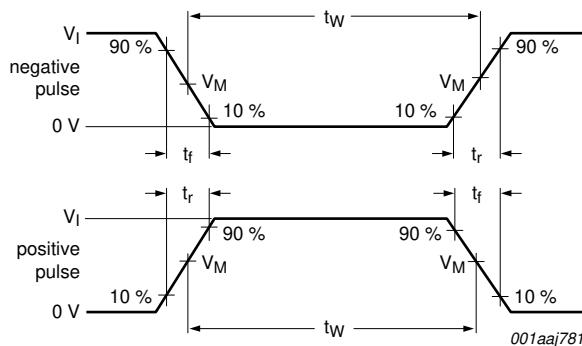
Transition times: transition time (t_t) = HIGH LOW (t_{THL}) or LOW HIGH (t_{TLH}) transition times.

Measurement points are given in [Table 8](#), test circuit in [Figure 6](#) and test data in [Table 9](#)

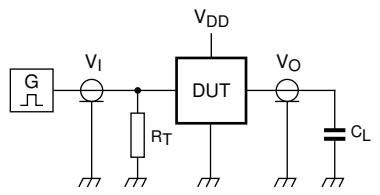
Fig 5. Waveforms showing propagation delays for MR to Qn and CP to Q0, minimum MR and CP pulse widths

Table 8. Measurement points

Supply voltage	Input	Output	
V_{DD} 5 V to 15 V	V_I V_{DD} or V_{SS}	V_M 0.5 V_{DD}	V_M 0.5 V_{DD}



a. Input waveforms



b. Test circuit

Test data is given in [Table 9](#).

Definitions test circuit:

DUT = Device Under Test;

C_L = load capacitance, including the jig and probe capacitance;

R_L = load resistance, which should be equal to the output impedance of the pulse generator.

Fig 6. Test circuit for measuring switching times

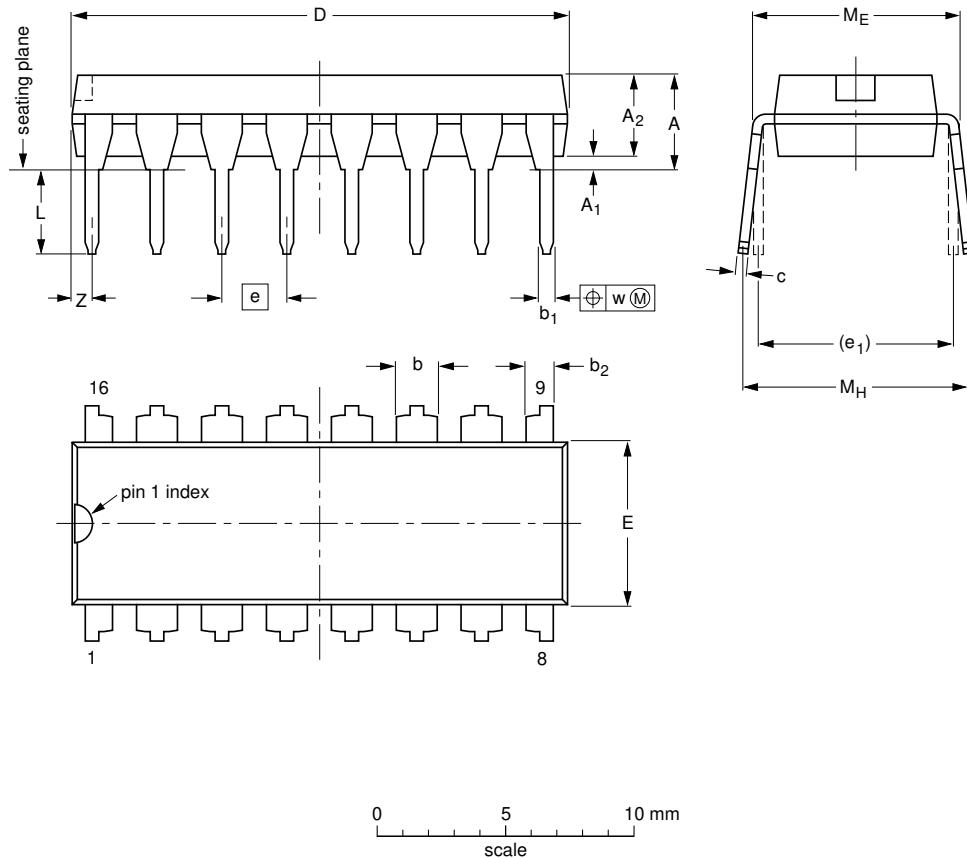
Table 9. Test data

Supply voltage	Input	Load
V_{DD} 5 V to 15 V	V_I V_{SS} or V_{DD}	t_r, t_f $\leq 20 \text{ ns}$ C_L 50 pF

12. Package outline

DIP16: plastic dual in-line package; 16 leads (300 mil)

SOT38-4



DIMENSIONS (inch dimensions are derived from the original mm dimensions)

UNIT	A max.	A ₁ min.	A ₂ max.	b	b ₁	b ₂	c	D ⁽¹⁾	E ⁽¹⁾	e	e ₁	L	M _E	M _H	w	Z ⁽¹⁾ max.
mm	4.2	0.51	3.2	1.73 1.30	0.53 0.38	1.25 0.85	0.36 0.23	19.50 18.55	6.48 6.20	2.54	7.62	3.60 3.05	8.25 7.80	10.0 8.3	0.254	0.76
inches	0.17	0.02	0.13	0.068 0.051	0.021 0.015	0.049 0.033	0.014 0.009	0.77 0.73	0.26 0.24	0.1	0.3	0.14 0.12	0.32 0.31	0.39 0.33	0.01	0.03

Note

1. Plastic or metal protrusions of 0.25 mm (0.01 inch) maximum per side are not included.

OUTLINE VERSION	REFERENCES			EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	JEITA		
SOT38-4					95-01-14 03-02-13

Fig 7. Package outline SOT38-4 (DIP16)

SO16: plastic small outline package; 16 leads; body width 3.9 mm

SOT109-1

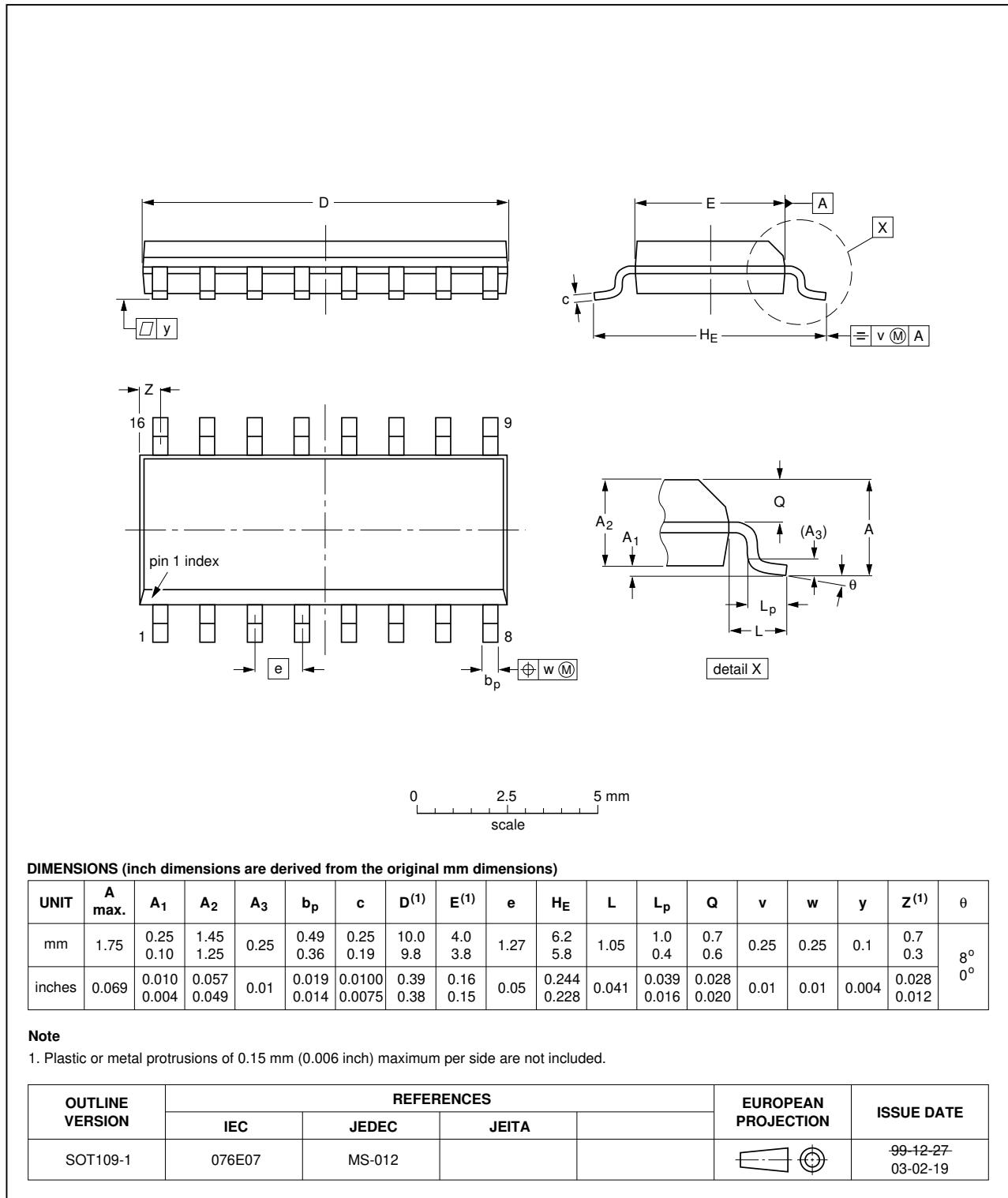


Fig 8. Package outline SOT109-1 (SO16)

13. Revision history

Table 10. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
HEF4040B v.8	20111117	Product data sheet	-	HEF4040B v.7
Modifications:		<ul style="list-style-type: none">• Legal pages updated.• Changes in "General description" and "Features and benefits".		
HEF4040B v.7	20111010	Product data sheet	-	HEF4040B v.6
HEF4040B v.6	20091125	Product data sheet	-	HEF4040B v.5
HEF4040B v.5	20090709	Product data sheet	-	HEF4040B v.4
HEF4040B v.4	20090304	Product data sheet	-	HEF4040B_CNV v.3
HEF4040B_CNV v.3	19950101	Product specification	-	HEF4040B_CNV v.2
HEF4040B_CNV v.2	19950101	Product specification	-	-

14. Legal information

14.1 Data sheet status

Document status ^{[1][2]}	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

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